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**Information technology — Process
assessment — Requirements for
process measurement frameworks**

*Technologies de l'information — Évaluation du processus —
Exigences relatives au cadres de mesure du processus*

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Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organization to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in fields of mutual interest. Other international organizations, governmental and non-governmental, in liaison with ISO and IEC, also take part in the work. In the field of information technology, ISO and IEC have established a joint technical committee, ISO/IEC JTC 1.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of document should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO and IEC shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the WTO principles in the Technical Barriers to Trade (TBT) see the following URL: [Foreword - Supplementary information](#)

The committee responsible for this document is ISO/IEC JTC 1, *Information technology, SC 7, Software and systems engineering*.

Introduction

This International Standard provides requirements for process measurement frameworks that support and enable the assessment of process quality characteristics, from conceptualization to empirical validation. In process measurement frameworks, measurement of a process quality characteristic produces a composite measure (e.g. process capability levels of ordinal scale in ISO/IEC 33020). Examples of process quality characteristics that are constructs (theoretical concepts) include process capability, process security, process agility, and process safety. The main users of this International Standard are developers of process measurement frameworks and process assessment models. Conformity to this International Standard ensures that any process measurement framework is developed with reliable structures or elements which will generate quality composite measures.

This International Standard is part of a set of International Standards designed to provide a consistent and coherent framework for the assessment of process quality characteristics, based on objective evidence resulting from implementation of the processes. The framework for assessment covers processes employed in the development, maintenance, and use of systems across the information technology domain and those employed in the design, transition, delivery, and improvement of services. The set of International Standards, as a whole, addresses process quality characteristics of any type. Results of assessment can be applied for improving process performance, or for identifying and addressing risks associated with application of processes.

This International Standard provides requirements for the development of process measurement frameworks, such as ISO/IEC 33020. These can then be used to define process assessment models, conformant to ISO/IEC 33004, that can be employed for process assessments conformant with ISO/IEC 33002. The overall architecture and content of the series is described in ISO/IEC 33001.

Several International Standards in the ISO/IEC 330xx family of standards for process assessment are intended to replace and extend parts of the ISO/IEC 15504 series of Standards. ISO/IEC 33001, Annex A provides a detailed record of the relationship between the ISO/IEC 330xx family and the ISO/IEC 15504 series.

Information technology — Process assessment — Requirements for process measurement frameworks

1 Scope

This International Standard sets out the requirements for process measurement frameworks for use in process assessment. The requirements defined in this International Standard form a structure which

- a) establish the requirements for process measurement frameworks in the context of process assessment,
- b) establish the requirements for the validation of process measurement frameworks for use in process assessment, and
- c) establish requirements that are applicable to any process measurement frameworks to develop composite measures across domains.

This International Standard is applicable to the development of process measurement frameworks for any process quality characteristic across all application domains.

[Annex A](#) presents a map of terminologies used in this International Standard. [Annex B](#) provides an explanation of construct specifications. [Annex C](#) reviews statistical validation methods. [Annex D](#) provides some methods including references that can be utilized in implementing the requirements for process measurement frameworks. These Annexes will be moved to a guide for constructing process measurement frameworks to be developed as part of the set of International Standards.

NOTE ISO/IEC 33020 is a process measurement framework for assessment of process capability based on this International Standard.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies

ISO/IEC 15939:2007, *Systems and software engineering — Measurement process*

ISO/IEC 33001:2015, *Information technology — Process assessment — Concepts and terminology*